## imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



### Contact us

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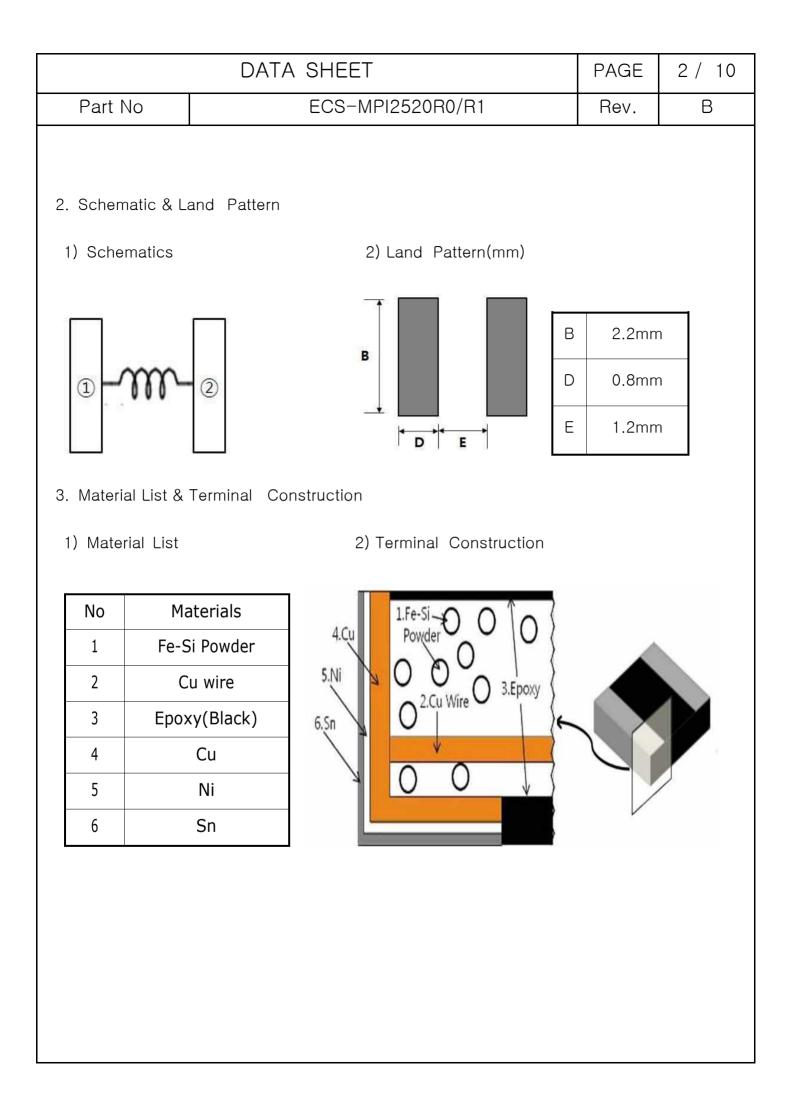
<u>Rev. : B</u> DATE : DEC. 15. 2017

## ECS-MPI2520

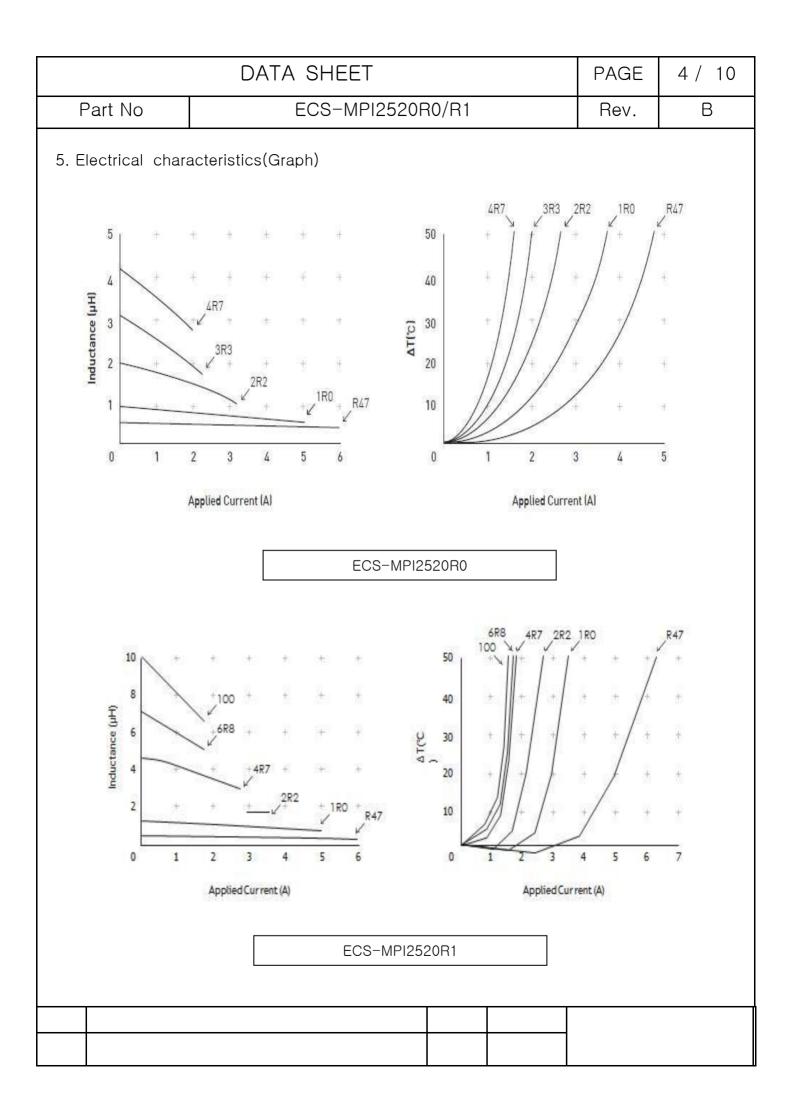
## **SMD** Power Inductor



		DATA SH	HEET		PAG	ie 1	/ 10		
	Part No	art No ECS-MPI2520R0/R1							
	Shape and Dim Shape	nension(mm)							
2)	Dimensions(mm)								
		Top view	Side view	Bottom view					
		B     A	→   + _ +		В				
	Item	A(mm	B(mm)	C(mm)		D(mm)			
	ECS-MPI2520R0 ECS-MPI2520R1	2.5 ± 2.5 ±	$2.0 \pm 0.2$ $2.0 \pm 0.2$	1.0 max 1.2 max		$6 \pm 0.25$ $6 \pm 0.25$			
		Revision Hi			Write	Review	Approval		
NO		Note	3101 y	Date	VIIIC				
1		Initial Release		2017.6.01					
2	Re	evised height indicator ir	n PN	2017. 12. 15			1		



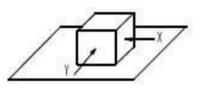
	PAGE	3 / 10								
Part No		ECS	S-MPI2	520R0/R1		Rev.	В			
4. Electrical Performance 1) Test condition : 1MHz, 0.10V 2) DCR @ 25℃										
Part Number	Code Note a	OCL (uH) ± 20% Note b	Isat (A) Note d	Irms (A) Note f	DCR (mΩ) (Typ)	DCR (mΩ) (max) Note g	K-factor			
ECS-MPI2520R0-R47-R	В	0.47	4.4	4.1	28	33.6	2887			
ECS-MPI2520R0-1R0-R	с	0.9	3.2	3.2	50	60	1925			
ECS-MPI2520R0-1R5-R	D	1.5	2.6	2.4	80	96	1444			
ECS-MPI2520R0-2R2-R	E	2.2	2.4	2.2	103	123.6	1283			
ECS-MPI2520R0-3R3-3	F	3.3	1.6	1.6	190	228	1050			
ECS-MPI2520R0-4R7-R	G	4.7	1.4	1.4	240	288	825			
	1									
ECS-MPI2520R1-R47-R	Α	0.47	4.8	4.5	20	24	2310			
ECS-MPI2520R1-1R0-R	В	1	4	3.7	35	42	1925			
ECS-MPI2520R1-1R5-R	C	1.5	3.4	2.9	55	66	1444			
ECS-MPI2520R1-2R2-R	D	2.2	2.7	2.3	75	90	1255			
ECS-MPI2520R1-3R3-R	E	3.3	2.4	1.8	105	126	962			
ECS-MPI2520R1-4R7-R	F	4.7	1.9	1.6	150	180	825			
ECS-MPI2520R1-5R6-R	G	5.6	1.5	1.5	200	240	679			
ECS-MPI2520R1-6R8-R ECS-MPI2520R1-100-R	н	6.8	1.3	1.3	300	360	679 525			
EC3-MP12320R1-100-R	I	10	1.2	1.1	390	468	525			
Measuring Instruments: OCL:HP4284A (Agilent Technologies, or equivalent)DC Bias:HP4284A & HP42841B (Agilent Technologies, or equivalent)DC Resistance:4100ATC (or equivalent)Note a: Print Marking Code on each reel of product to define different part number.										
Note b: Test condition: 1MHz, 0.1V										
Note c: Test condition: 1 MHz, 0.1V										
Noted: Isat Amperes	Peak for a	approximat	ely 30% F	Roll-off (@25	5°C)					
Note f: RMS current f temperature of the pa				without cor	e loss. It is re	ecommended t	nat the			
Note g: DCR @ 25℃										
					<u>г</u>					



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Part No	ECS-MPI2520R0/R1	Rev.	В

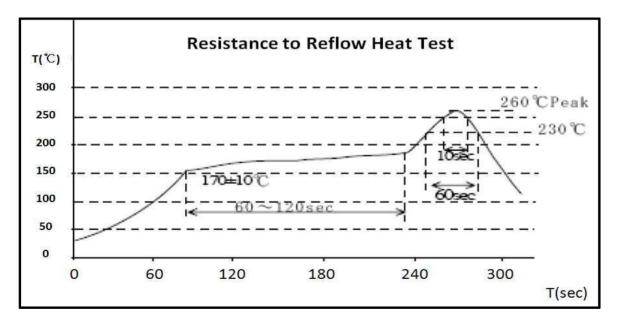
- 6. Mechanical characteristics testing items
- 1) Storage temperature  $-40 \sim +105^{\circ}$ C
- 2) Operation Temperature  $-40 \sim +105$ °C (Including coil's self-temperature rise)
- 3) External appearance: No external defects can be found in the visual inspection.
- 4) Electrode strength

No electrode detachment should be found when the device is pushed in two directions of X and Y with the force of 5.0N for  $60\pm1$  seconds after soldering between copper plate and the electrodes. (Refer to figure)



5) Heat endurance test

Inductance deviation is within  $\pm 5.0\%$  after reflow test be done for 3 times. according to the below chart, then the measurement shall be made in 2 hours after 1 hour storage under room ambient conditions



6) Vibration test

Inductance deviation is within  $\pm 5.0\%$  after 2 hour sweeping vibration in each three directions, namely, forward and backward, up and down, right and left. The frequency is  $10\sim55\sim10$ Hz and amplitude of 1 minute cycles is 1.5mm PP.

#### 7) Shock test

Inductance deviation is within  $\pm 5.0\%$  after the test with gum-block shock testing machine, once in each of the three perpendicular axis directions. The shock acceleration is  $981 \text{m/s}^2$ 

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Part No	ECS-MPI2520R0/R1	Rev.	В						
humidity of 90~9	tion is within $\pm 5.0\%$ after $500\pm12$ hours test under th 5% and temperature of $60\pm2$ °C. and 1 hours storage the device is wiped with dry cloth.								
9) High temperature Inductance deviat	e Storage test ion is within $\pm 5.0\%$ after $500\pm12$ hours test under the c $5\pm2\%$ and 1 hours storage under room ambient condition		nich						
	ion is within $\pm 5.0\%$ after 500 $\pm 12$ hours test under the c $0\pm 2$ °C and 1 hours storage under room ambient condit		nich						
for 30 minutes(Tra After 1000 cycles is tested within the 12) Board bent cha Inductance deviat	ect to -40℃ for 30 minutes hereafter it is subject to 105 ansition time is 1 minute maximum.) This constitutes on , it is then left in room temperature for I hour. After whic he next 1 hour and the inductance deviation is within	e cycle. h specimen ±5.0% n of the arro							
Specimen is subje for 30 minutes(Tra After 1000 cycles is tested within the 12) Board bent cha Inductance deviat at a rate of about 13) Solubility resista	ect to $-40$ °C for 30 minutes hereafter it is subject to 105 ansition time is 1 minute maximum.) This constitutes on , it is then left in room temperature for I hour. After which he next 1 hour and the inductance deviation is within aracteristic ion is within $\pm 5.0$ %, after apply pressure in the direction at 0.5mm/s until bent with reaches 2mm and hold for ance test	e cycle. h specimen ±5.0% n of the arro 30 seconds	S						
Specimen is subje for 30 minutes(Tra After 1000 cycles is tested within the 12) Board bent cha Inductance deviat at a rate of about 13) Solubility resistand Inductance deviat 25°C±5°C. Then it	ect to $-40$ °C for 30 minutes hereafter it is subject to 105 ansition time is 1 minute maximum.) This constitutes on , it is then left in room temperature for I hour. After which he next 1 hour and the inductance deviation is within aracteristic ion is within $\pm 5.0$ %, after apply pressure in the direction at 0.5mm/s until bent with reaches 2mm and hold for	e cycle. h specimen ±5.0% n of the arro 30 seconds	s						

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Part No	ECS-MPI2520R0/R1	Rev.	В
15) Humidity load I	ife test		

Inductance deviation is within  $\pm 5.0\%$  and no structure and electric defects can be found after  $1000\pm12$  hours test under the condition of relative humidity of  $80\sim85\%$  and temperature of  $85\pm2\%$  and allowable current loaded and 1 hour storage under room ambient conditions after which device is tested within the next 2 hours

16) High-temperature electrification test

The component is left in a constant temperature chamber of temperature  $105\pm2$ °C applying the rated current for  $1000\pm12$  hours after the soldering heat resistance test, and then the component is left at room temperature and normal humidity for  $2\pm1$  hours. After that, any surface defects shouldn't be found and the rate of inductance against its initial value should be within  $\pm5\%$ 

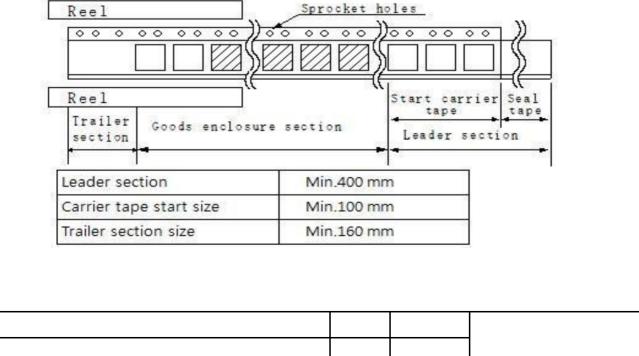
17) Low-temperature electrification test

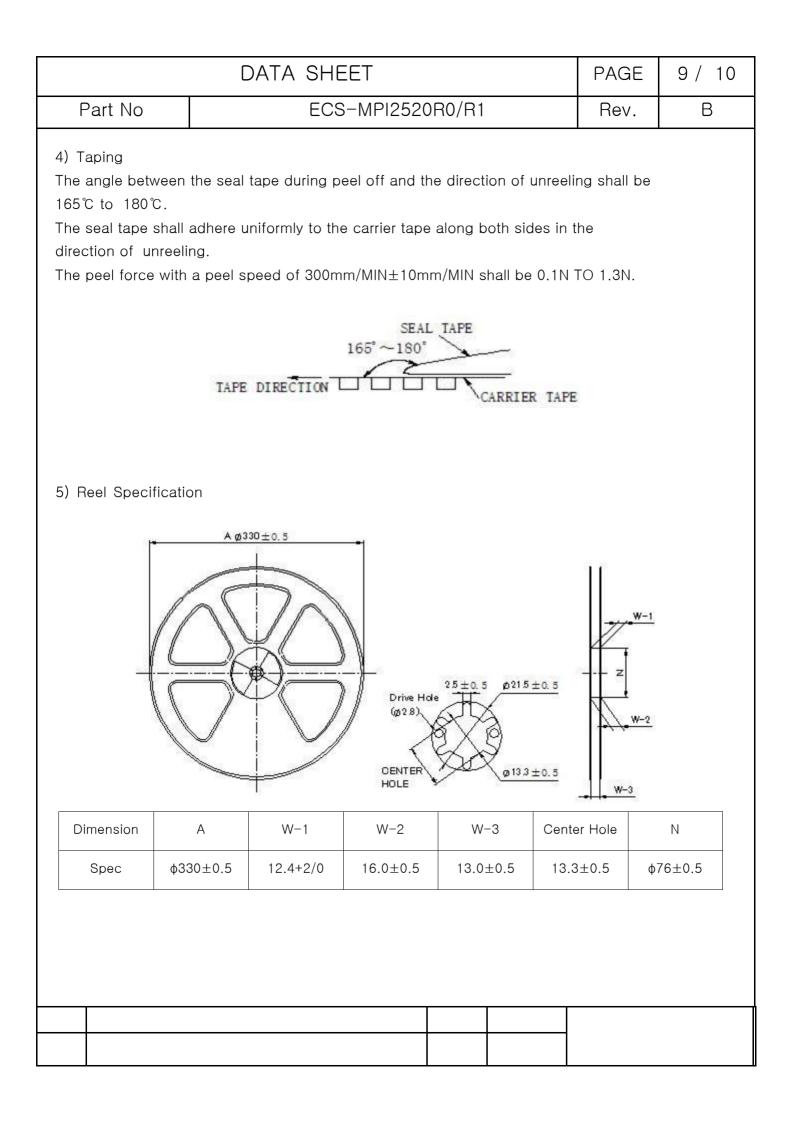
The component is left in a constant temperature chamber of temperature  $-40\pm3$ °C applying the rated current for  $1000\pm12$  hours after the soldering heat resistance test, and then the component is left at room temperature and normal humidity for  $2\pm1$  hours. After that, any surface defects shouldn't be found and the rate of inductance against its initial value should be within  $\pm5\%$ 

Application Notice / Handling

- 1) Temperature and humidity conditions: less than 40°C and 70% RH.
- 2) Products should be used within 6 months.
- 3) The packaging material should be kept where no chlorine or sulfur exists in the air.
- 4) Do not touch the electrodes (soldering terminals) with fingers as this may lead to deterioration of solderability.
- 5) The use of tweezers or vacuum pick-ups is strongly recommended for individual components.
- 6) Bulk handling should ensure that abrasion and mechanical shock are minimized

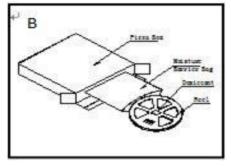
ata		ECS	-MPI2	2520R	80/R1			Rev.		В			
ata													
l (mm	<ul><li>7. Packaging Standard</li><li>1) Packaging data</li></ul>												
<u> </u>	Component L(mm) W(mm) H(mm) Wt(g) Quantity									ntity			
2.70	)	2.2	20		1.20		0.03		3,0	00			
$ \begin{array}{c c} \hline \\ \hline $													
W A0		K0								P1			
.0± 2.3± 0.3 0.1	2.8± 0.1	1.3± 0.1	0.3± 0.1	4.0± 0.1	3.9± 0.1	1.75 ±0.1	1.5+ 0.1	1.5± 0.1	4.0± 0.1	2.0± 0.05			
\ \	<u>т</u> <u>ко</u> W <u>А0</u> 0± 2.3±	Т Р0 Ф Ф Ф КО М АО ВО 0± 2.3± 2.8±	Т Р Ф Ф Ф Ф Ф Ф Ф Ф Ф Ф Ф Ф Ф	$\begin{array}{c c} T & P0 & \hline \\ \hline$	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	$W = A0 = B0 = K0 = T = P = E = D0 = D1 = 0.3\pm 0.3\pm 0.3\pm 0.3\pm 0.3\pm 0.3\pm 0.3\pm 0.3\pm$	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$			

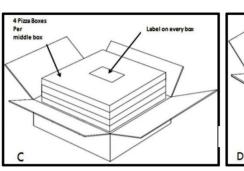




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#### 6) Packing Materials





Packing Materials	B. Pizza Box			C. Middle Box			D. Large Box		
Dimension(mm)	L	W	Н	L	W	Н	L	W	Н
	335	335	50	355	355	230	720	370	255

7) Packing Specification

2middle box/Large box, 4Reel/Middle box, 1Reel/Pizza box, 7500pcs/Reel, Total 60000pcs(Large Box) Reel Dimensions : Ø 330 × 12(mm)

#### 8. Environmental substances requirement

1) RoHs Compliance & Halogen Compliance

Test Items	Unit	Test Method	MDL	Results
Cd	mg/kg	With reference to IEC62321:2008, ICP	0.5	N.D.
Pb	mg/kg	With reference to IEC62321:2008, ICP	5	N.D.
Hg	mg/kg	With reference to IEC62321:2008, ICP	2	N.D.
Cr VI	mg/kg	With reference to IEC62321:2008, UV-VIS	1	N.D.
PBBs	mg/kg	With reference to IEC62321:2008, GC-MS	5	N.D.
PBDEs	mg/kg	With reference to IEC62321:2008, GC-MS	5	N.D.
Br	mg/kg	BS EN 14582:2007, IC	30	N.D.
CI	mg/kg	BS EN 14582:2007, IC	30	N.D.
F	mg/kg	BS EN 14582:2007, IC	30	N.D.
I	mg/kg	BS EN 14582:2007, IC	50	N.D.

Note

1) N.D. = Not detected(< MDL)

2) mg/kg = ppm

- 3) MDL = Method Detection Limit
- 4) Test instrument : SGS TEST KOREA